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FGA70N30T 300V, 70A PDP IGBT

Features

- · High current capability
- Low saturation voltage: $V_{CE(sat)} = 1.5V @ I_C = 40A$
- · High input impedance
- · Fast switching
- · RoHS complaint

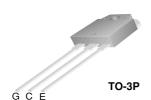
Application

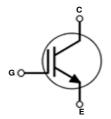
. PDP System



General Description

Using Novel Trench IGBT Technology, Fairchild's new sesries of trench IGBTs offer the optimum performance for PDP applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

| Symbol | Description | | Ratings | Units |
|--------------------------|--|--------------------------|-------------|-------|
| V _{CES} | Collector-Emitter Voltage | | 300 | V |
| V _{GES} | Gate-Emitter Voltage | | ±30 | V |
| I _{C pulse(1)*} | Pulsed Collector Current | @ T _C = 25°C | 160 | A |
| | Maximum Power Dissipation | @ T _C = 25°C | 201 | W |
| P_{D} | Maximum Power Dissipation | @ T _C = 100°C | 90.6 | W |
| TJ | Operating Junction Temperature | | -55 to +150 | °C |
| T _{stg} | Storage Temperature Range | | -55 to +150 | °C |
| T _L | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds | | 300 | °C |

Thermal Characteristics

| Symbol | Parameter | Тур. | Max. | Units |
|-----------------------|---|------|------|-------|
| $R_{\theta JC}(IGBT)$ | Thermal Resistance, Junction-to-Case | | 0.62 | °C/W |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient | | 40 | °C/W |

Notes

(1)Repetitive test , pluse width = 100usec , Duty = 0.2

^{*} Ic_pluse limited by max Tj

Package Marking and Ordering Information

| Device Marking | Device | Package | Packaging Type | Qty per Tube | Max Qty per Box |
|----------------|-------------|---------|-------------------|--------------|--------------------|
| FGA70N30T | FGA70N30TTU | TO-3P | Tube 30ea | | - |

Electrical Characteristics $T_C = 25^{\circ}C$ unless otherwise noted

| Symbol | Parameter | Test Conditions | Min. | Тур. | Max. | Units |
|---|--|--|------|------|-------|-------|
| Off Charac | teristics | | | | | |
| BV _{CES} | Collector-Emitter Breakdown Voltage | V _{GE} = 0V, I _C = 250uA | 300 | | | V |
| ΔB _{VCES} / ΔΤ _J | Temperature Coefficient of Breakdown Voltage | V _{GE} = 0V, I _C = 250uA | | 0.2 | | V/°C |
| I _{CES} | Collector Cut-Off Current | $V_{CE} = V_{CES}, V_{GE} = 0V$ | | | 250 | uA |
| I _{GES} | G-E Leakage Current | $V_{GE} = V_{GES}, V_{CE} = 0V$ | | | ± 400 | nA |
| On Charac | teristics | | | | | |
| V _{GE(th)} | G-E Threshold Voltage | $I_C = 250uA$, $V_{CE} = V_{GE}$ | 3.0 | 4.5 | 5.5 | V |
| | | I _C =20A, V _{GE} = 15V | | 1.2 | 1.5 | V |
| V | Collector to Emitter | I _C =40A, V _{GE} = 15V | | 1.5 | | V |
| OL(Sat) | Saturation Voltage | I _C =70A, V _{GE} = 15V T _C = 25°C | | 1.8 | | V |
| | | I _C = 70A, V _{GE} = 15V T _C = 125°C | | 1.9 | | V |
| | Characteristics | | | | 1 | |
| C _{ies} | Input Capacitance | V _{CE} = 30V, V _{GE} = 0V | | 3000 | | pF |
| C _{oes} | Output Capacitance | f = 1MHz | | 160 | | pF |
| C _{res} | Reverse Transfer Capacitance | | | 110 | | pF |
| Switching | Characteristics | | | | | |
| t _{d(on)} | Turn-On Delay Time | $V_{CC} = 200V, I_{C} = 40A$ $R_{G} = 15\Omega, V_{GE} = 15V$ Resistive Load, $T_{C} = 25^{\circ}C$ | | 32 | | ns |
| t _r | Rise Time | | | 90 | | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 175 | | ns |
| t _f | Fall Time | 7 | | 170 | 300 | ns |
| t _{d(on)} | Turn-On Delay Time | | | 30 | | ns |
| t _r | Rise Time | $V_{CC} = 200V, I_{C} = 40A$ $R_{G} = 15\Omega, V_{GE} = 15V$ Resistive Load, $T_{C} = 125^{\circ}C$ | | 90 | | ns |
| t _{d(off)} | Turn-Off Delay Time | | | 185 | | ns |
| t _f | Fall Time | | | 235 | | ns |
| Q _g | Total Gate Charge | | | 125 | | nC |
| Q _{ge} | Gate-Emitter Charge | $V_{CE} = 200V, I_{C} = 40A$ $V_{GE} = 15V$ | | 25 | | nC |
| Q _{gc} | Gate-Collector Charge | - VGE - 10V | | 55 | | nC |

Typical Performance Characteristics

Figure 1. Typical Output Characteristics

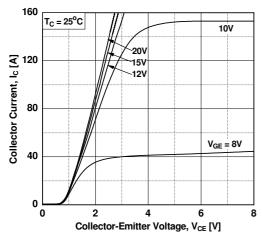


Figure 3. Typical Saturation Voltage Characteristics

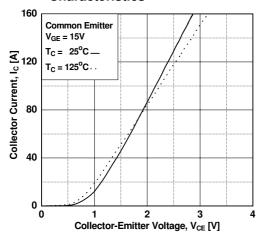


Figure 5. Saturation Voltage vs. Case
Temperature at Variant Current Level

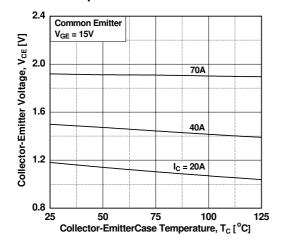


Figure 2. Typical Output Characteristics

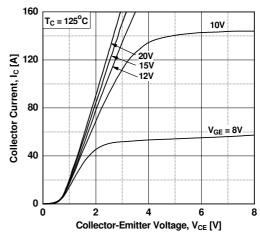


Figure 4. Transfer Characteristics

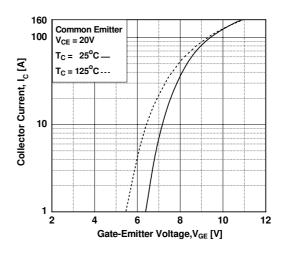
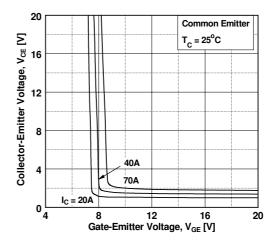


Figure 6. Saturation Voltage vs. V_{GE}



Typical Performance Characteristics (Continued)

Figure 7. Saturation Voltage vs. V_{GE}

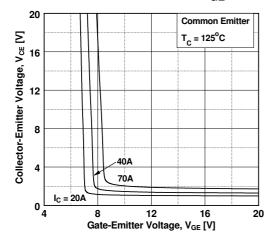


Figure 9. Gate Charge Characteristics

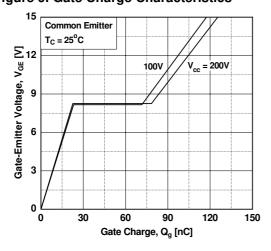


Figure 11. Turn-on Characteristics vs.
Gate Resistance

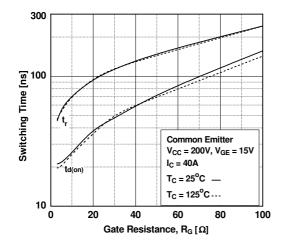


Figure 8. Capacitance Characteristics

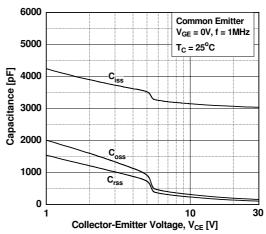


Figure 10. SOA Characteristics

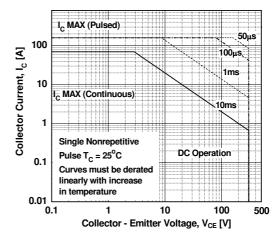
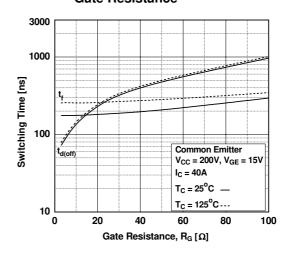


Figure 12. Turn-off Characteristics vs.
Gate Resistance



Typical Performance Characteristics (Continued)

Figure 13. Turn-on Characteristics vs. Collector Current

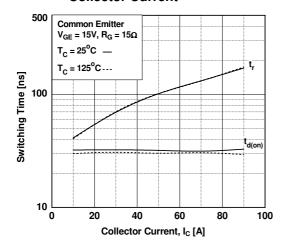


Figure 14. Turn-off Characteristics vs. Collector Current

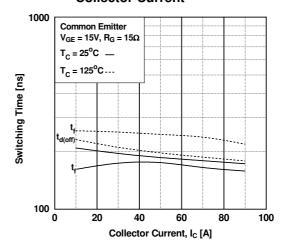


Figure 15. Switching Loss vs. Gate Resistance

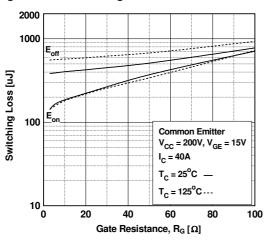


Figure 16. Switching Loss vs. Collector Current

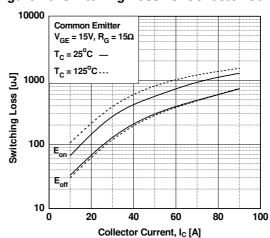
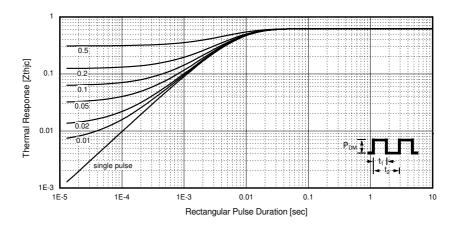
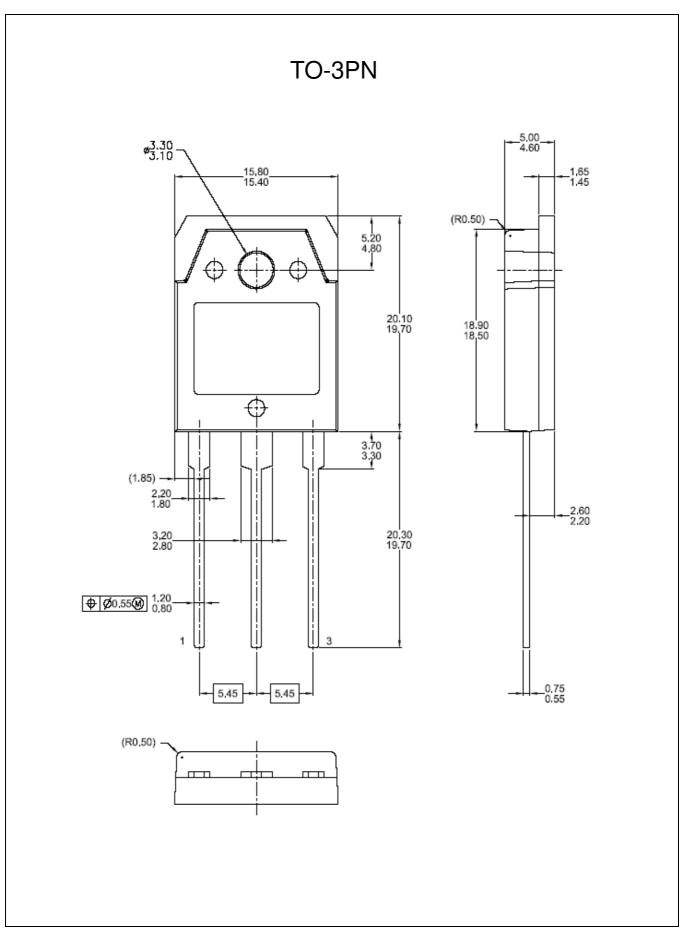


Figure 17. Transient Thermal Impedance of IGBT









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